

STD1LNK60Z-1 STQ1NK60ZR - STN1NK60Z

N-CHANNEL 600V - 13Ω - 0.8A - TO-92 - IPAK - SOT-223 Zener-Protected SuperMESH™ Power MOSFET

General features

Туре	V _{DSS}	R _{DS(on)}	I _D	Pw
STD1LNK60Z-1	600V	<15Ω	0.8A	25W
STQ1NK60ZR	600V	<15Ω	0.3A	3W
STN1NK60Z	600V	<15Ω	0.3A	3.3W

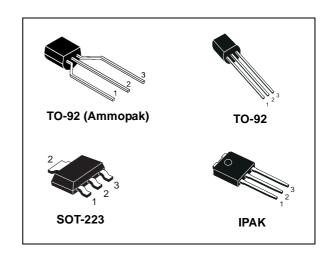
- 100% avalanche tested
- Extremely high dv/dt capability
- Gate charge minimized
- ESD improved capability
- New high voltage benchmark

Description

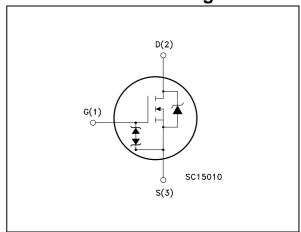
The SuperMESH™ series is obtained through an extreme optimization of ST's well established strip-based PowerMESH™ layout. In addition to pushing on-resistance significantly down, special care is taken to ensure a very good dv/dt capability for the most demanding applications. Such series complements ST full range of high voltage MOSFETs including revolutionary MDmesh™ products.

Applications

■ Switching application



Internal schematic diagram



Order codes

Sales Type	Marking	Package	Packaging
STD1LNK60Z-1	D1LNK60Z	IPAK	TUBE
STQ1NK60ZR	Q1NK60ZR	TO-92	BULK
STQ1NK60ZR-AP	Q1NK60ZR	TO-92	AMMOPAK
STN1NK60Z	1NK60Z	SOT-223	TAPE & REEL

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter		Value		Unit
Symbol	rarameter	IPAK	TO-92	SOT-223	Onit
V _{DS}	Drain-Source Voltage (V _{GS} = 0)		600		V
V _{DGR}	Drain-Gate Voltage ($R_{GS} = 20K\Omega$)		600		V
V _{GS}	Gate-Source Voltage		± 30		V
I _D	Drain Current (continuous) at T _C = 25°C 0.8 0.3 0.3				Α
I _D	Drain Current (continuous) at T _C =100°C	t (continuous) at T _C =100°C 0.5 0.189		Α	
I _{DM} ⁽¹⁾	Drain Current (pulsed)	3.2		1.2	Α
P _{TOT}	Total Dissipation at T _C = 25°C	25	3	3.3	W
	Derating Factor	0.24	0.25	0.26	W/°C
V _{ESD(G-D)}	Gate source ESD(HBM-C=100pF, R=1.5KΩ)		800		V
dv/dt ⁽²⁾	Peak Diode Recovery voltage slope	4.5		V/ns	
T _J T _{stg}	Operating Junction Temperature Storage Temperature		-55 to 15	60	°C

^{1.} Pulse width limited by safe operating area

Table 2. Thermal resistance

Symbol	Parameter		Unit		
Syllibol	raiametei	IPAK	TO-92	SOT-223	Oille
R _{thj-case}	Thermal resistance junction-case Max	5			°C/W
R _{thj-a}	Thermal resistance junction-ambient Max	100	120	37.87 ⁽¹⁾	°C/W
R _{thj-lead}	Thermal resistance junction-lead Max		40		°C/W
T _I	Maximum lead temperature for soldering purpose	275 260		°C	

^{1.} When mounted on 1 inch² FR-4 board, 2 Oz Cu

Table 3. Avalanche data

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche Curent, Repetitive or Noy-Repetitive (pulse width limited by Tj Max)	0.8	А
E _{AS}	Single pulse avalanche Energy (starting Tj=25°C, Id=Iar, Vdd=50V)	60	mJ

^{2.} $I_{SD} \le 0.3A$, di/dt $\le 200A/\mu s$, $V_{DD} = 80\%V_{(BR)DSS}$

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test Condictions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-Source Breakdown Voltage	$I_D = 1 \text{mA}, V_{GS} = 0$	600			V
I _{DSS}	Zero Gate Voltage Drain Current (V _{GS} = 0)	V_{DS} = Max Rating, V_{DS} = MaxRating @125°C			1 50	μΑ μΑ
I _{GSS}	Gate Body Leakage Current (V _{DS} = 0)	V _{GS} = ±20V			±10	μΑ
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 50\mu A$	3	3.75	45	V
R _{DS(on)}	Static Drain-Source On Resistance	V _{GS} = 10V, I _D = 0.4A		13	15	Ω

Table 5. Dynamic

Symbol	Parameter	Test Condictions	Min.	Тур.	Max.	Unit
g _{fs} ⁽¹⁾	Forward Transconductance	$V_{DS} = 15V, I_D = 0.4A$		0.5		S
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	V _{DS} =25V, f=1 MHz, V _{GS} =0		94 17.6 2.8		pF pF pF
Coss eq ⁽²⁾ .	Equivalent Output Capacitance	V _{GS} =0, V _{DS} =0V to 480V		11		pF
Q _g Q _{gs} Q _{gd}	Total Gate Charge Gate-Source Charge Gate-Drain Charge	V_{DD} =480V, I_{D} = 0.8A V_{GS} =10V (see Figure 11)		4.9 1 2.7	6.9	nC nC nC

^{1.} Pulsed: pulse duration=300µs, duty cycle 1.5%

^{2.} $C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} inceases from 0 to 80% V_{DSS}

Table 6. Switching times

Symbol	Parameter	Test Condictions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r t _{d(off)} t _f	Turn-on Delay Time Rise Time Turn-off Delay Time Fall Time	V_{DD} =300 V, I_{D} = 0.4A, R_{G} =4.7 Ω , V_{GS} =10V (see Figure 19)		5.5 5 13 28		ns ns ns

Table 7. Source drain diode

Symbol	Parameter	Test Condictions	Min	Тур.	Max	Unit
I _{SD}	Source-drain Current				0.8	Α
I _{SDM} ⁽¹⁾	Source-drain Current (pulsed)				2.4	Α
V _{SD} ⁽²⁾	Forward on Voltage	I _{SD} =0.8A, V _{GS} =0			1.6	V
t _{rr} Q _{rr} I _{RRM}	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	I_{SD} =0.8A, di/dt = 100A/ μ s, V_{DD} =20V, Tj=25°C		135 216 3.2		ns nC A
t _{rr} Q _{rr} I _{RRM}	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	I _{SD} =0.8A, di/dt = 100A/μs, V _{DD} =20V, Tj=150°C		140 224 3.2		ns nC A

^{1.} Pulse width limited by safe operating area

Table 8. Gate-source zener diode

Symbol	Parameter	Test Condictions	Min.	Тур.	Max.	Unit
BV _{GSO} ⁽¹⁾	Gate-source Braekdown Voltage	Igs=±1mA (Open Drain)	30			V

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

^{2.} Pulsed: pulse duration=300µs, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area for IPAK

Figure 2. Thermal impedance for IPAK

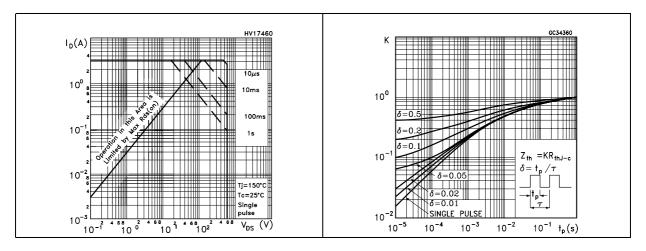


Figure 3. Safe operating area for TO-92

Figure 4. Thermal impedance for TO-92

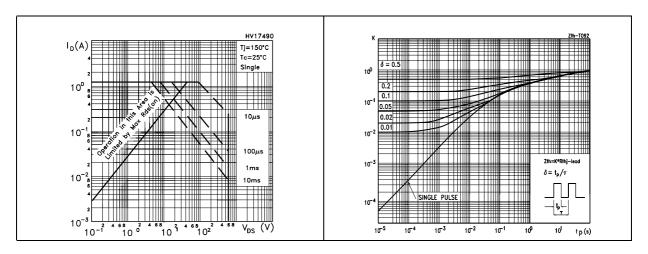
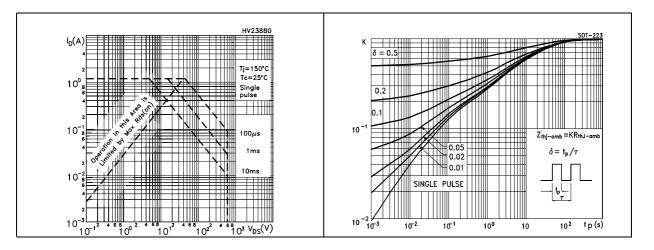


Figure 5. Safe operating area for SOT-223

Figure 6. Thermal impedance for SOT-223



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Figure 7. Output characterisics

Figure 8. Transfer characteristics

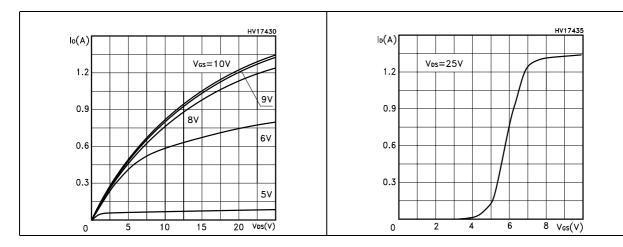


Figure 9. Transconductance

Figure 10. Static drain-source on resistance

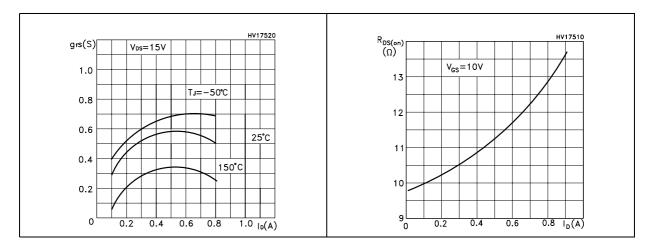


Figure 11. Gate charge vs gate-source voltage Figure 12. Capacitance variations

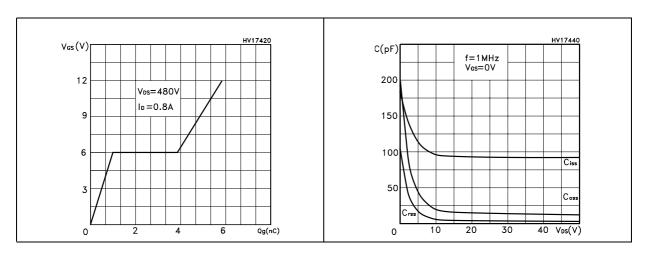
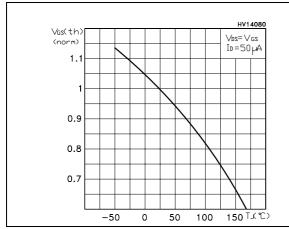


Figure 13. Normalized gate threshold voltage vs temperature

Figure 14. Normalized on resistance vs temperature



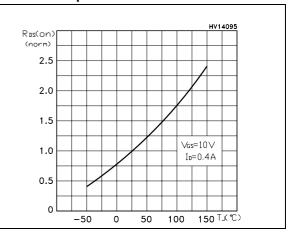
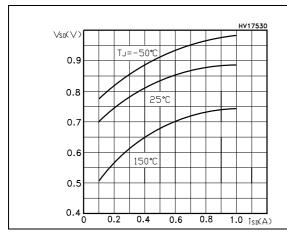


Figure 15. Source-drain diode forward characteristics

Figure 16. Normalized B_{VDSS} vs temperature



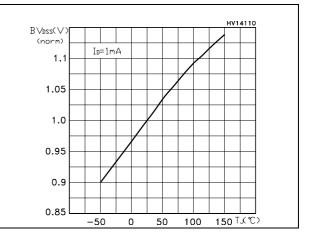
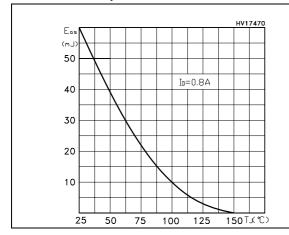
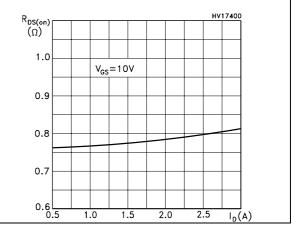


Figure 17. Maximum avalanche energy vs temperature

Figure 18. Max Id Current vs Tc





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3 Test circuit

Figure 19. Switching times test circuit for resistive load

Figure 20. Gate charge test circuit

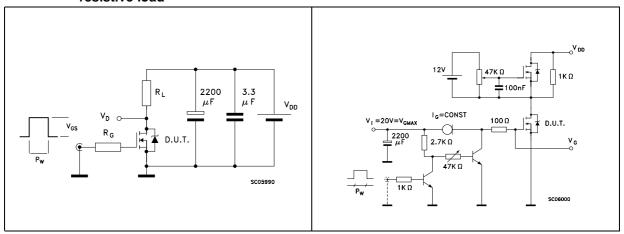


Figure 21. Test circuit for inductive load switching and diode recovery times

Figure 22. Unclamped Inductive load test circuit

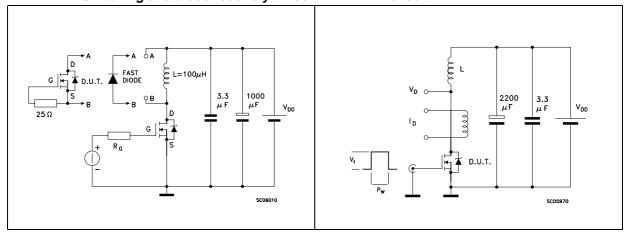
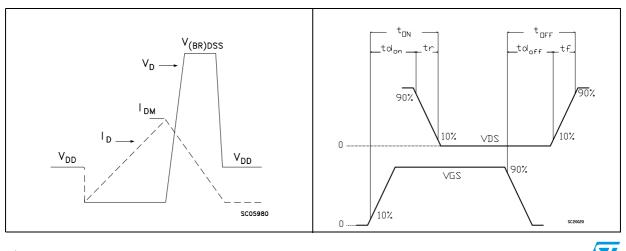


Figure 23. Unclamped inductive waveform

Figure 24. Switching time waveform

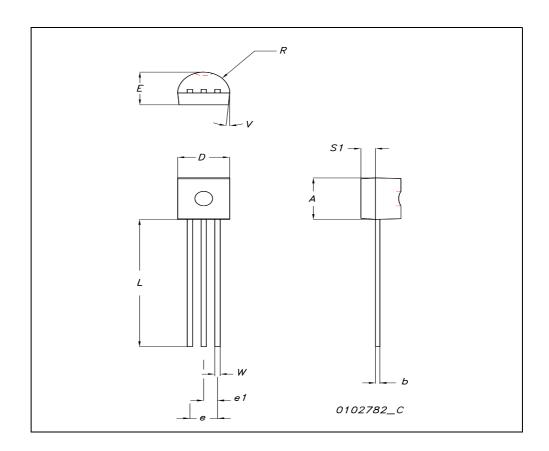


4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

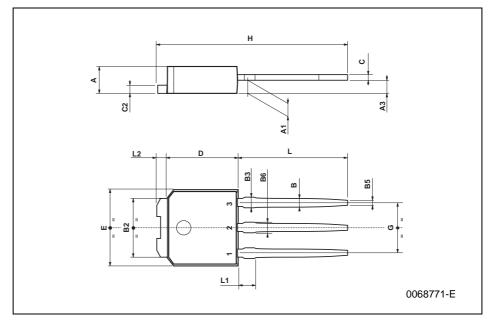
TO-92 MECHANICAL DATA

DIM	mm.				inch	
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	4.32		4.95	0.170		0.194
b	0.36		0.51	0.014		0.020
D	4.45		4.95	0.175		0.194
E	3.30		3.94	0.130		0.155
е	2.41		2.67	0.094		0.105
e1	1.14		1.40	0.044		0.055
L	12.70		15.49	0.50		0.610
R	2.16		2.41	0.085		0.094
S1	0.92		1.52	0.036		0.060
W	0.41		0.56	0.016		0.022
V		5°			5°	



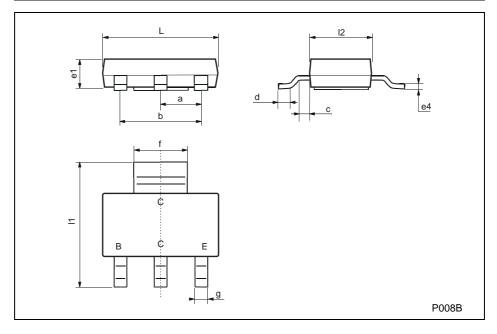
TO-251 (IPAK) MECHANICAL DATA

DIM.		mm			inch	
DIIVI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
Α	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
А3	0.7		1.3	0.027		0.051
В	0.64		0.9	0.025		0.031
B2	5.2		5.4	0.204		0.212
В3			0.85			0.033
B5		0.3			0.012	
В6			0.95			0.037
С	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
E	6.4		6.6	0.252		0.260
G	4.4		4.6	0.173		0.181
Н	15.9		16.3	0.626		0.641
L	9		9.4	0.354		0.370
L1	0.8		1.2	0.031		0.047
L2		0.8	1		0.031	0.039



SOT-223 MECHANICAL DATA

DIM.	mm			mils		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
а	2.27	2.3	2.33	89.4	90.6	91.7
b	4.57	4.6	4.63	179.9	181.1	182.3
С	0.2	0.4	0.6	7.9	15.7	23.6
d	0.63	0.65	0.67	24.8	25.6	26.4
e1	1.5	1.6	1.7	59.1	63	66.9
e4			0.32			12.6
f	2.9	3	3.1	114.2	118.1	122.1
g	0.67	0.7	0.73	26.4	27.6	28.7
l1	6.7	7	7.3	263.8	275.6	287.4
l2	3.5	3.5	3.7	137.8	137.8	145.7
L	6.3	6.5	6.7	248	255.9	263.8



5 Revision history

Table 9. Revision history

Date	Revision	Changes	
19-Mar-2003	1	First Release	
15-May-2003	2	Removed DPAK	
09-Jun-2003	3	Final datasheet	
17-Nov-2004	4	Inserted SOT-223	
15-Feb-2005	5	Modified Figure 3.	
07-Sep-2005	6	Inserted ecopak indication	
22-Feb-2006	7	New template	

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